

# MOS FIELD EFFECT TRANSISTOR $\mu$ PA679TB

# N/P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

#### **DESCRIPTION**

The  $\mu$  PA679TB is a switching device, which can be driven directly by a 2.5 V power source.

The  $\mu$  PA679TB features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

#### **FEATURES**

- 2.5 V drive available
- Low on-state resistance

 $\begin{array}{ll} \text{N-ch} & \text{R}_{DS(\text{on})1} = 0.57 \; \Omega \; \text{MAX.} \; (\text{VGs} = 4.5 \, \text{V}, \; \text{I}_D = 0.30 \, \text{A}) \\ & \text{R}_{DS(\text{on})3} = 0.88 \; \Omega \; \text{MAX.} \; (\text{VGs} = 2.5 \, \text{V}, \; \text{I}_D = 0.15 \, \text{A}) \\ \text{P-ch} & \text{R}_{DS(\text{on})1} = 1.45 \; \Omega \; \text{MAX.} \; (\text{VGs} = -4.5 \, \text{V}, \; \text{I}_D = -0.20 \, \text{A}) \\ & \text{R}_{DS(\text{on})3} = 2.98 \; \Omega \; \text{MAX.} \; (\text{VGs} = -2.5 \, \text{V}, \; \text{I}_D = -0.15 \, \text{A}) \end{array}$ 

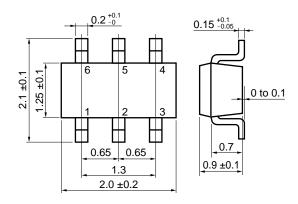
• Two MOS FET circuits in same size package as SC-70

## ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA679TB	SC-88 (SSP)

Marking: YA

## PACKAGE DRAWING (Unit: mm)



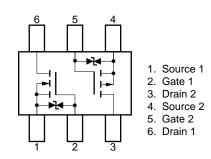
# ABSOLUTE MAXIMUM RATINGS ( $T_A = 25$ °C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	20 / –20	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±12 / ∓12	V
Drain Current (DC)	I <sub>D(DC)</sub>	$\pm 0.35$ / $\mp 0.25$	Α
Drain Current (pulse) Note1	ID(pulse)	±1.40 / ∓1.00	Α
Total Power Dissipation (2 units) Note2	PT	0.2	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

2. Mounted on FR-4 board of 2500 mm<sup>2</sup> x 1.1 mm

## PIN CONNECTION (Top View)



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

Caution This product is electrostatic-sensitive device due to low ESD capability and shoud be handled with caution for electrostatic discharge.

V<sub>ESD</sub> =  $\pm 100$  V TYP. (C = 200 pF, R = 0  $\Omega$ , Single pulse)

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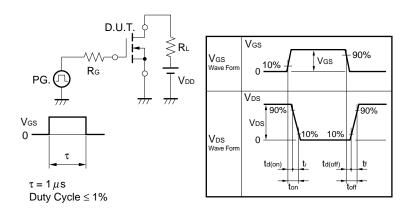
# **ELECTRICAL CHARACTERISTICS**

# (1) N-ch PART (T<sub>A</sub> = 25°C)

( )						
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	V <sub>DS</sub> = 20.0 V, V <sub>GS</sub> = 0 V			1.0	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ±12.0 V, V <sub>DS</sub> = 0 V			±10	μΑ
Gate Cut-off Voltage Note	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10.0 V, I <sub>D</sub> = 1.0 mA	0.50	1.00	1.50	V
Forward Transfer Admittance Note	y <sub>fs</sub>	V <sub>DS</sub> = 10.0 V, I <sub>D</sub> = 0.30 A	0.25	0.75		S
Drain to Source On-state Resistance Note	RDS(on)1	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.30 A		0.38	0.57	Ω
	RDS(on)2	V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 0.30 A		0.41	0.60	Ω
	RDS(on)3	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 0.15 A		0.60	0.88	Ω
Input Capacitance	Ciss	V <sub>DS</sub> = 10.0 V		28		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		11		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		7		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10.0 V, I <sub>D</sub> = 0.30 A		20		ns
Rise Time	tr	V <sub>GS</sub> = 4.0 V		51		ns
Turn-off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 10 Ω		94		ns
Fall Time	tf			87		ns
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	I <sub>F</sub> = 0.35 A, V <sub>GS</sub> = 0 V		0.84		V

**Note** Pulsed: PW  $\leq$  350  $\mu$ s, Duty cycle  $\leq$  2%

# TEST CIRCUIT SWITCHING TIME

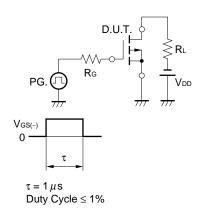


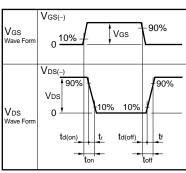
# (2) P-ch PART (T<sub>A</sub> = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	V <sub>DS</sub> = -20.0 V, V <sub>GS</sub> = 0 V			-1.0	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ∓12.0 V, V <sub>DS</sub> = 0 V			∓10	μΑ
Gate Cut-off Voltage Note	V <sub>GS(off)</sub>	V <sub>DS</sub> = -10.0 V, I <sub>D</sub> = -1.0 mA	-0.80	-1.30	-1.80	V
Forward Transfer Admittance Note	<b>y</b> fs	V <sub>DS</sub> = -10.0 V, I <sub>D</sub> = -0.20 A	0.2	0.6		S
Drain to Source On-state Resistance Note	RDS(on)1	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -0.20 A		1.17	1.45	Ω
	RDS(on)2	V <sub>GS</sub> = -4.0 V, I <sub>D</sub> = -0.20 A		1.25	1.55	Ω
	RDS(on)3	V <sub>GS</sub> = -2.5 V, I <sub>D</sub> = -0.15 A		2.25	2.98	Ω
Input Capacitance	Ciss	V <sub>DS</sub> = -10.0 V		29		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		15		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		3		pF
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{DD} = -10.0 \text{ V}, I_D = -0.20 \text{ A}$		23		ns
Rise Time	tr	V <sub>GS</sub> = -4.0 V		39		ns
Turn-off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 10 Ω		50		ns
Fall Time	tf			33		ns
Body Diode Forward Voltage	VF(S-D)	I <sub>F</sub> = 0.25 A, V <sub>GS</sub> = 0 V		0.88		V

**Note** Pulsed: PW  $\leq$  350  $\mu$ s, Duty cycle  $\leq$  2%

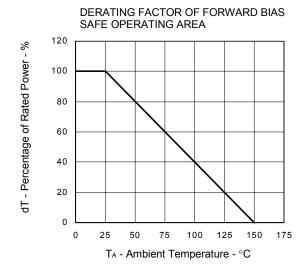
# TEST CIRCUIT SWITCHING TIME

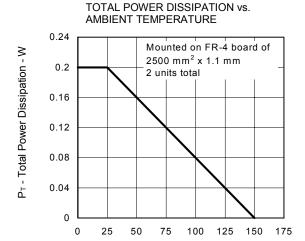




# TYPICAL CHARACTERISTICS

## (1) N-ch PART ( $T_A = 25^{\circ}C$ )

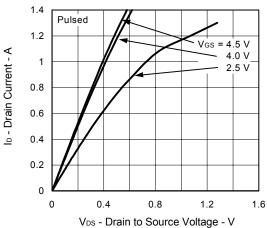




## 1.4 Pulsed 1.2 Vgs = 4.5 V 4.0 V 1 2.5 V 8.0

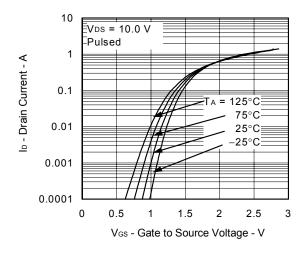
DRAIN CURRENT vs.

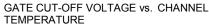
DRAIN TO SOURCE VOLTAGE

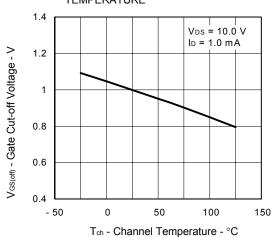




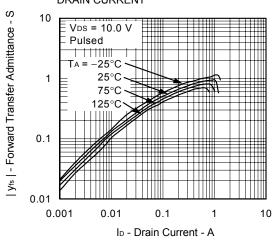
TA - Ambient Temperature - °C







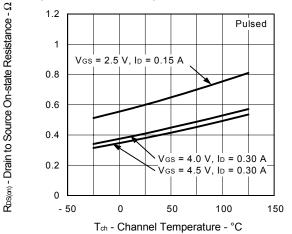
#### FORWARD TRANSFER ADMITTANCE vs. **DRAIN CURRENT**



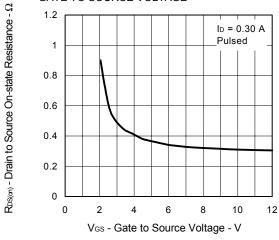
 $\mathsf{R}_{\mathsf{DS}(\varpi)}$  - Drain to Source On-state Resistance -  $\Omega$ 

 $\mathsf{R}_{\mathsf{DS}(m)}$  - Drain to Source On-state Resistance -  $\Omega$ 

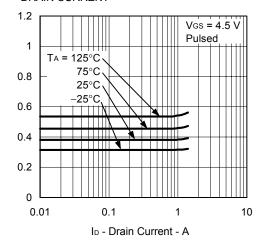
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



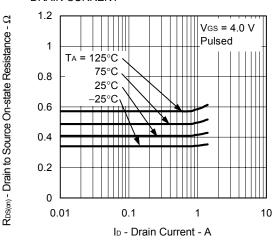
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



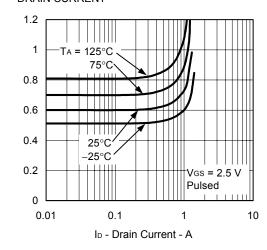
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



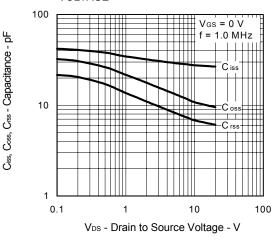
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



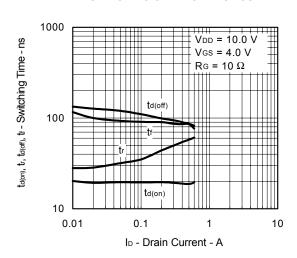
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

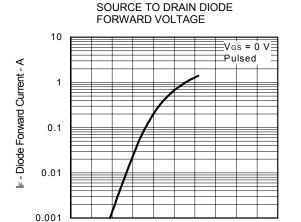


1.2

1.4

## SWITCHING CHARACTERISTICS





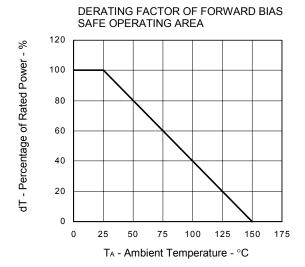
8.0

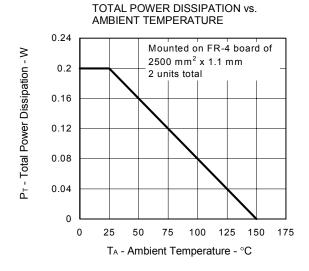
 $V_{F(S\text{-}D)}$  - Source to Drain Voltage - V

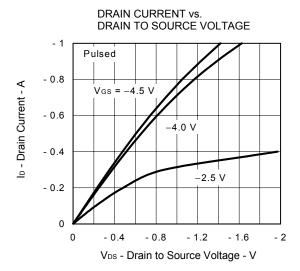
0.4

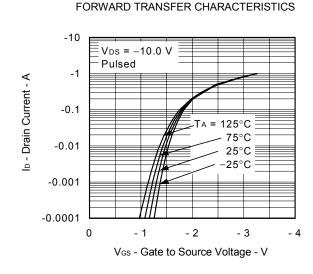
0.6

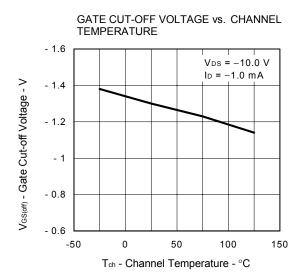
# (2) P-ch PART ( $T_A = 25$ °C)

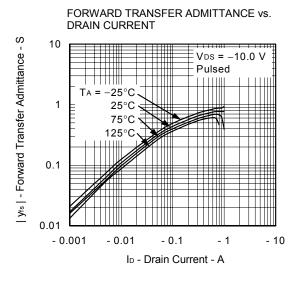






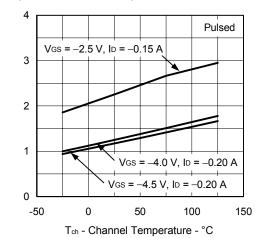




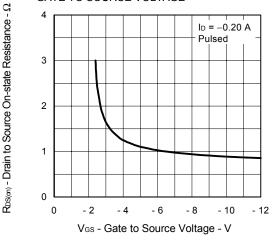


 $\mathsf{R}_{\mathsf{DS}(\varpi)}$  - Drain to Source On-state Resistance -  $\Omega$ 

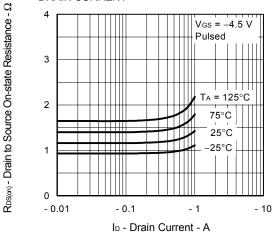
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



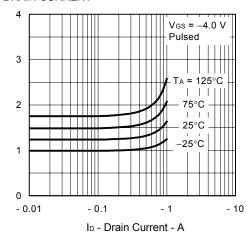
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



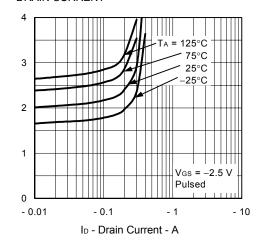
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



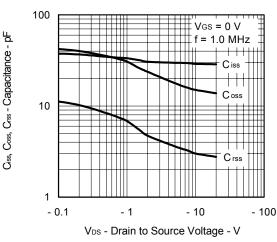
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



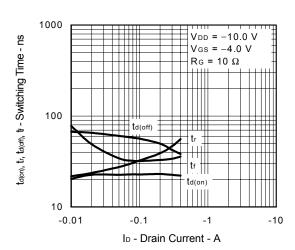
 $\mathsf{R}_{\mathsf{DS}(\varpi)}$  - Drain to Source On-state Resistance -  $\Omega$ 

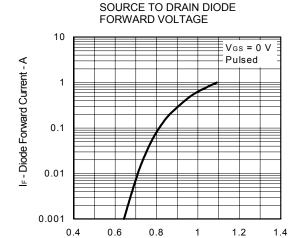
 $\mathsf{R}_{\mathsf{DS}(m)}$  - Drain to Source On-state Resistance -  $\Omega$ 

1.2

1.4

## SWITCHING CHARACTERISTICS





 $V_{F(S\text{-}D)}$  - Source to Drain Voltage - V

0.4

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